

**AOL1428**
**N-Channel Enhancement Mode Field Effect Transistor**
**General Description**

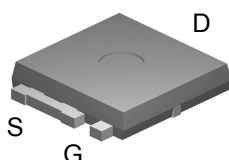
The AOL1428 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge. This device is suitable for use as a high side switch in SMPS and general purpose applications.

- RoHS Compliant
- Halogen and Antimony Free Green Device\*

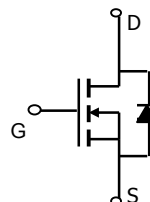
**Features**

$V_{DS}$  (V) = 30V  
 $I_D$  = 45A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 9.5m $\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 16m $\Omega$  ( $V_{GS}$  = 4.5V)  
 UIS Tested  
 $R_g, C_{iss}, C_{oss}, C_{rss}$  Tested

Ultra SO-8™ Top View



Bottom tab  
connected to  
drain


**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                                                 | Symbol         | Maximum    | Units            |
|-----------------------------------------------------------|----------------|------------|------------------|
| Drain-Source Voltage                                      | $V_{DS}$       | 30         | V                |
| Gate-Source Voltage                                       | $V_{GS}$       | $\pm 20$   | V                |
| Continuous Drain Current <sup>B</sup>                     | $I_D$          | 49         | A                |
| $T_C=25^\circ\text{C}$                                    |                |            |                  |
| $T_C=100^\circ\text{C}$                                   | $I_D$          | 34         | A                |
| Pulsed Drain Current                                      | $I_{DM}$       | 120        |                  |
| Continuous Drain Current <sup>H</sup>                     | $I_{DSM}$      | 11         | A                |
| $T_A=25^\circ\text{C}$                                    |                |            |                  |
| $T_A=70^\circ\text{C}$                                    | $I_{DSM}$      | 9          | A                |
| Avalanche Current <sup>C</sup>                            | $I_{AR}$       | 30         | A                |
| Repetitive avalanche energy $L=0.3\text{mH}$ <sup>C</sup> | $E_{AR}$       | 135        | mJ               |
| Power Dissipation <sup>B</sup>                            | $P_D$          | 43         | W                |
| $T_C=25^\circ\text{C}$                                    |                |            |                  |
| $T_C=100^\circ\text{C}$                                   | $P_D$          | 21         | W                |
| Power Dissipation <sup>A</sup>                            | $P_{DSM}$      | 2.2        | W                |
| $T_A=25^\circ\text{C}$                                    |                |            |                  |
| $T_A=70^\circ\text{C}$                                    | $P_{DSM}$      | 1.5        | W                |
| Junction and Storage Temperature Range                    | $T_J, T_{STG}$ | -55 to 175 | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ | Max | Units              |
|------------------------------------------|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 19  | 25  | $^\circ\text{C/W}$ |
| $t \leq 10\text{s}$                      |                 |     |     |                    |
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 45  | 55  | $^\circ\text{C/W}$ |
| Steady-State                             |                 |     |     |                    |
| Maximum Junction-to-Case <sup>C</sup>    | $R_{\theta JC}$ | 2.5 | 3.5 | $^\circ\text{C/W}$ |
| Steady-State                             |                 |     |     |                    |

Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                          | Min | Typ         | Max    | Units            |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------|-----|-------------|--------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                     |     |             |        |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$                                           | 30  |             |        | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=24\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^{\circ}\text{C}$                |     |             | 1<br>5 | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                        |     |             | 0.1    | $\mu\text{A}$    |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                              | 1   | 1.9         | 2.5    | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$                                            | 120 |             |        | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=20\text{A}$<br>$T_J=125^{\circ}\text{C}$                 |     | 7.7<br>11.0 | 9.5    | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=20\text{A}$                                             |     | 13          | 16.0   | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=20\text{A}$                                               |     | 40          |        | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                                |     | 0.74        | 1.0    | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                     |     |             | 46     | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                     |     |             |        |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                          |     | 1000        |        | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                     |     | 340         |        | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                     |     | 100         |        | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                           |     | 1.3         |        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                     |     |             |        |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=20\text{A}$                        |     | 18          |        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                     |     | 8.5         |        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                     |     | 3.1         |        | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                     |     | 4.8         |        | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=0.75\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 5.6         |        | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                     |     | 5.5         |        | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                     |     | 18.5        |        | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                     |     | 5           |        | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 29          |        | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 24          |        | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device in a still air environment with  $T_A=25^{\circ}\text{C}$ .

B: The power dissipation  $P_D$  is based on  $T_{J(MAX)}=175^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=175^{\circ}\text{C}$ .

D: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=175^{\circ}\text{C}$ .

G: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

H: Surface mounted on a 1 in 2 FR-4 board with 2oz. Copper.

\* This device is guaranteed green after date code 8P11 (June 1<sup>ST</sup> 2008)

Rev3: Jul 2008

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

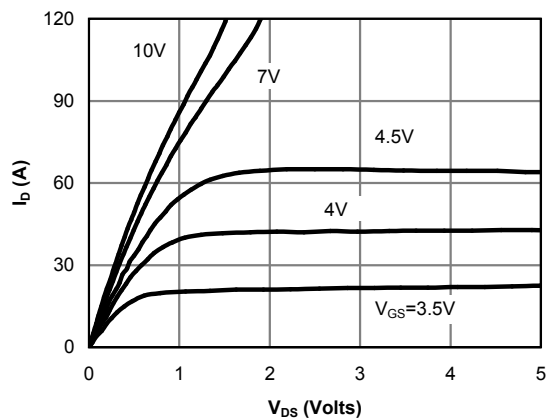


Figure 1: On-Region Characteristics

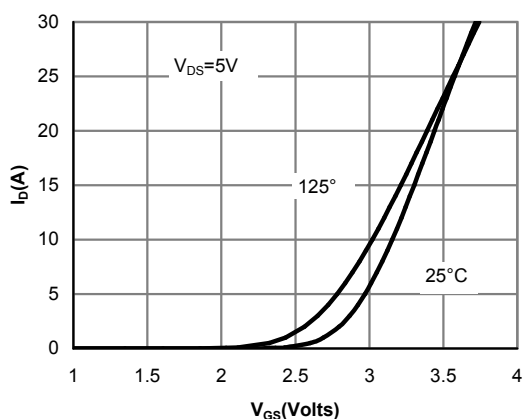


Figure 2: Transfer Characteristics

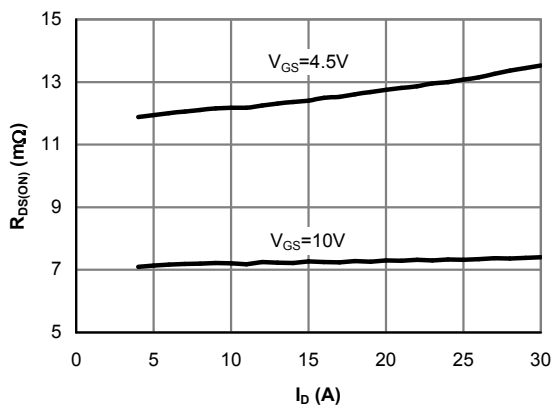


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

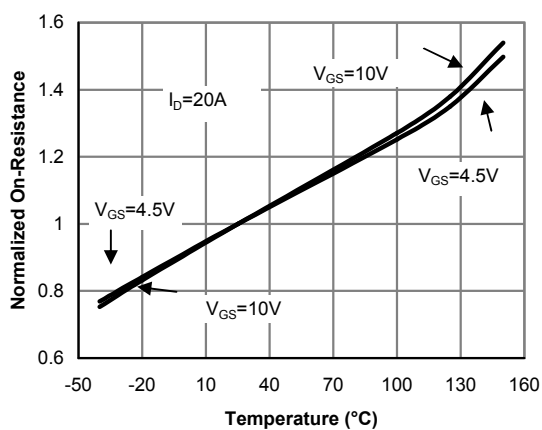


Figure 4: On-Resistance vs. Junction Temperature

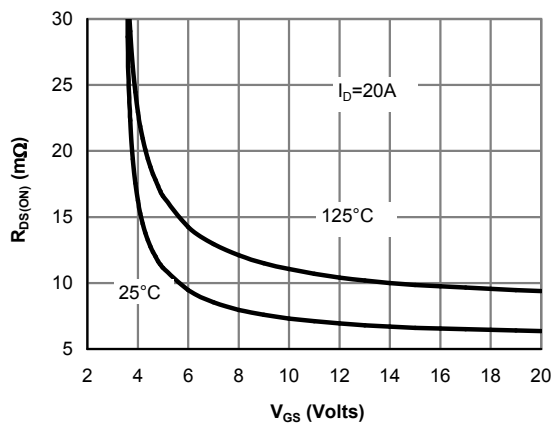


Figure 5: On-Resistance vs. Gate-Source Voltage

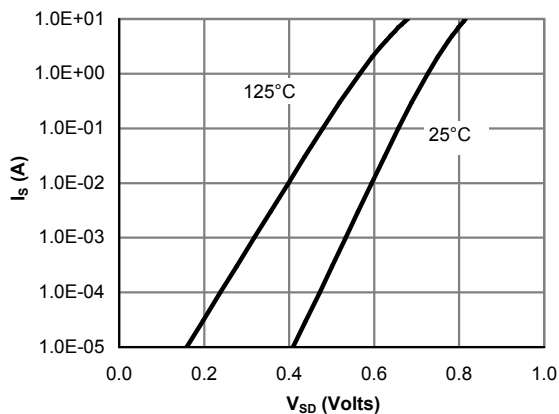


Figure 6: Body-Diode Characteristics

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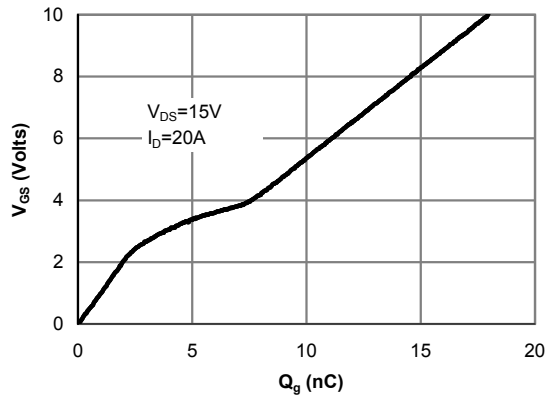


Figure 7: Gate-Charge Characteristics

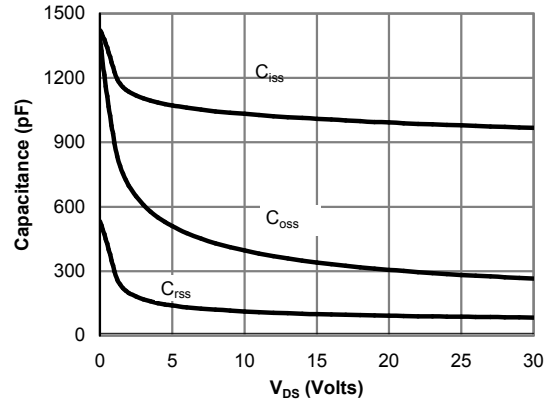


Figure 8: Capacitance Characteristics

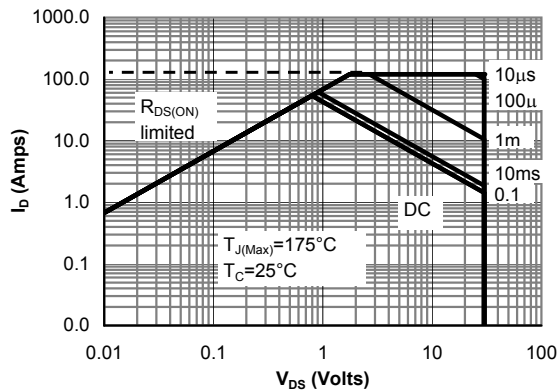


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

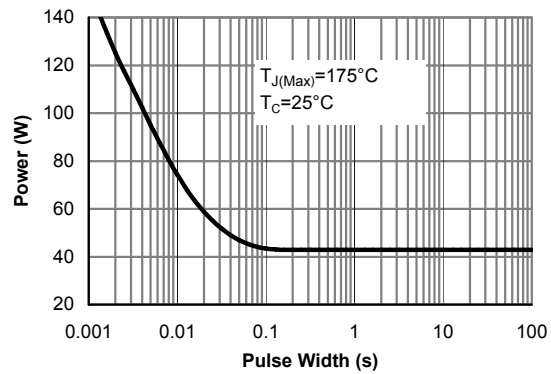


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

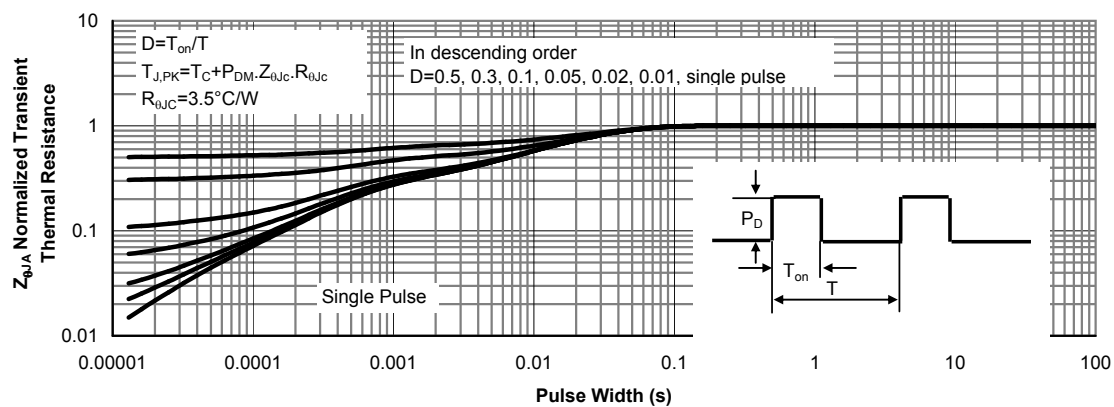


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

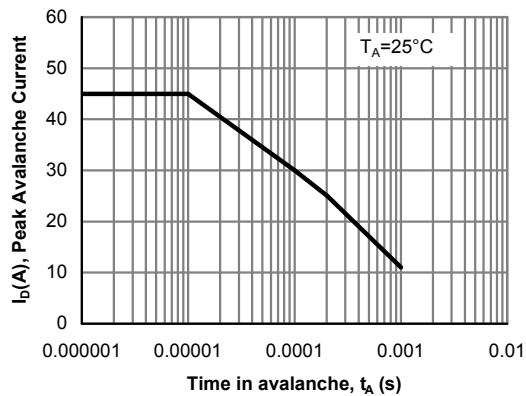


Figure 12: Single Pulse Avalanche capability

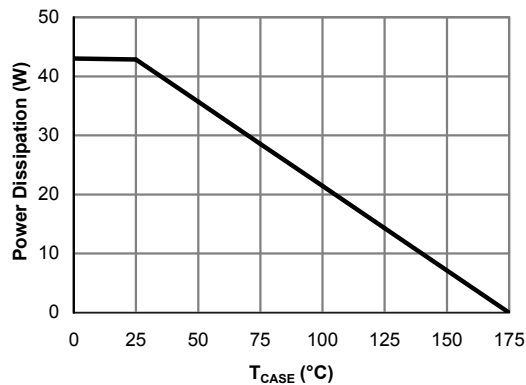


Figure 13: Power De-rating (Note B)

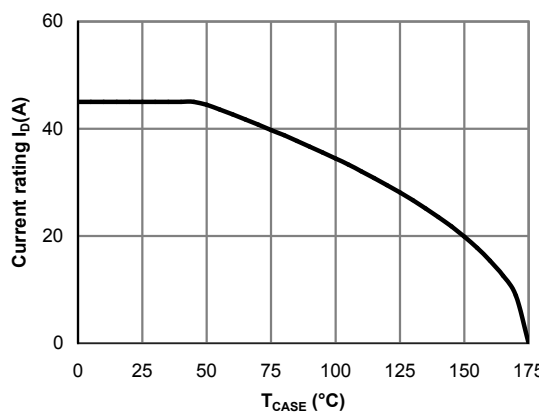


Figure 14: Current De-rating (Note B)

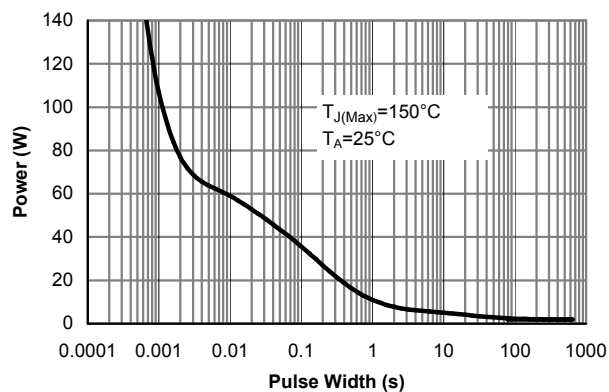


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)

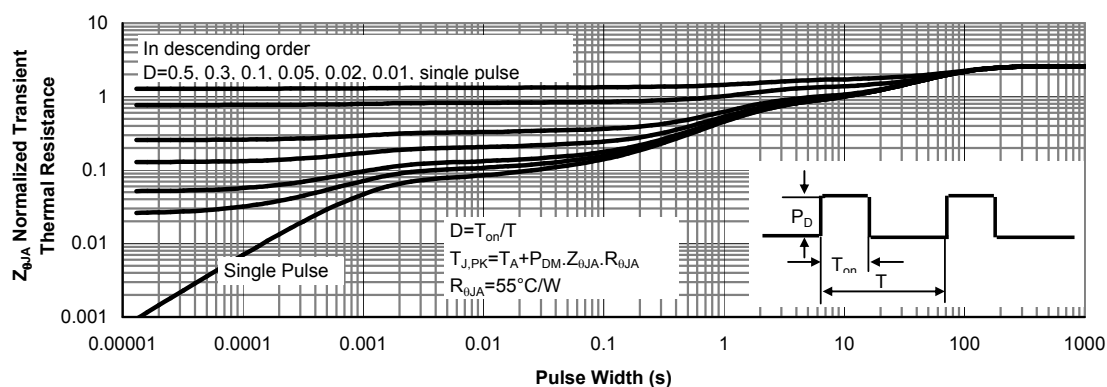
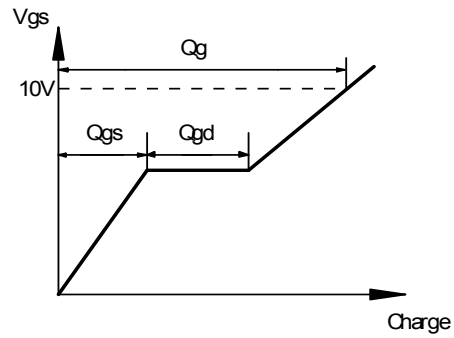
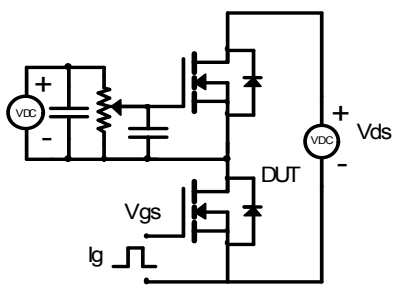
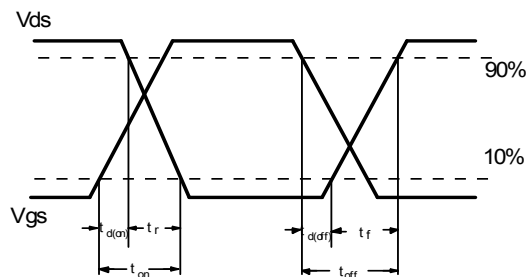
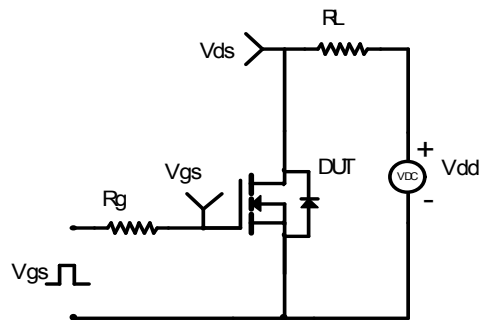


Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

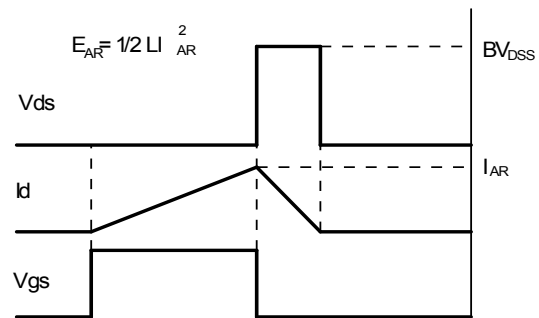
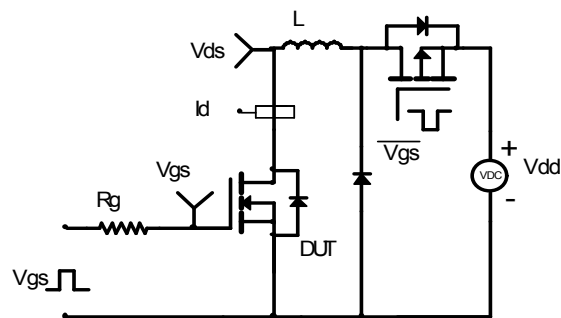
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms

